<b>                                      </b>	

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/815,201	LIAW, JHON JHY	
Examiner	Art Unit	
Jesse A. Fenty	2815	

	SEAR	CHED	
Class	Subclass	Date	Examiner
257	336, 344, 347, 412, 413	10/20/2006	JAF
257/e	27.098	10/20/2006	JAF
257/e	21.661	10/20/2006	JAF
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INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
257	336, 347	10/20/2006	JAF
257	412	10/20/2006	JAF

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
EAST	10/20/2006	JAF
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